

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10768443	WARE ET AL.
Examiner	Art Unit	
TRUNG Q NGUYEN	2829	

### SEARCHED

Class	Subclass	Date	Examiner
324	750-758, 158.1, 760-765,117r, 117H, 115	03/30/2009	QT

### SEARCH NOTES

Search Notes	Date	Examiner
Keywords: Test\$3, circuit\$3, transmitt\$3, receiv\$3 , wafer\$3, bandwidth\$1	03/25/2009	QT
Inventor Search and Plus Search are updated	03/30/2009	QT

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
PG-PUB Search	See attached search	03/25/2009	QT